

M368-2.

2.500V

TI /H/8446-2

LM368-2.5 Precision Voltage Reference

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Absolute Maximum Ratings (Note 7)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

| Input Voltage | 35V |
|-----------------------------|-------------------------------------|
| Power Dissipation | 600 mW |
| Storage Temperature Range | -60° C to $+150^{\circ}$ C |
| Operating Temperature Range | 0°C to +70°C |

Soldering Information

+ 300°C

TO-5 (H) Package (10 sec.) See AN-450 "Surface Mounting Methods and Their Effect on Product Reliability" (Appendix D) for other methods of soldering surface mount devices.

Electrical Characteristics (Note 1)

| | | LM368-2.5 | | | |
|--|---|--------------|-----------------------------|-----------------------------|---------------------------------|
| Parameter | Conditions | Typical | Tested Limit (Note 2) | Design Limit (Note 3) | Units (Max. unless noted) |
| V _{OUT} Error: LM368 | | ±0.02 | ±0.2 | | % |
| Line Regulation | $5.0V \le V_{IN} \le 30V$ | ±0.0001 | ±0.0005 | | %/V |
| Load Regulation (Note 8) | $0 \text{ mA} \leq I_{\text{SOURCE}} \leq 10 \text{ mA}$ | ± 0.0003 | ±0.0025 | | %/mA |
| Thermal Regulation | T = 20 mS (Note 4) | ± 0.005 | ±0.02 | | %/100 mW |
| Quiescent Current | | 350 | 550 | | μΑ |
| Change of Quiescent Current vs. V_{IN} | $5.0V \leq V_{IN} \leq 30V$ | 3 | 5 | | μA/V |
| Temperature Coefficient of V _{OUT} (see graph): LM368Y-2.5 (Note 5) LM368-2.5 | $\begin{array}{l} 0^{\circ}C \leq T_{A} \leq 70^{\circ}C \\ 0^{\circ}C \leq T_{A} \leq 70^{\circ}C \end{array}$ | ±11 ±15 | ±20 | ±30 | ppm/°C ppm/°C |
| Short Circuit Current | $V_{OUT} = 0$ | 30 | 70 | 100 | mA |
| Noise: 0.1–10 Hz 100 Hz–10 kHz | | 12 420 | | | uVp-p nV/√Hz |
| V _{OUT} Adjust Range | $0 \leq V_{PIN5} \leq V_{OUT}$ | 1.9–5.2 | | 2.2-5.0 | V min. |

Note 1: Unless otherwise noted, these specifications apply: T_A = 25°C, 4.9V \leq V_{IN} \leq 10.5V, 0 \leq I_{LOAD} \leq 0.5 mA, 0 \leq C_L \leq 200 pF.

Note 2: Tested Limits are guaranteed and 100% tested in production.

Note 3: Design Limits are guaranteed (but not 100% production tested) over the indicated temperature and supply voltage ranges. These limits are not used to calculate outgoing quality levels.

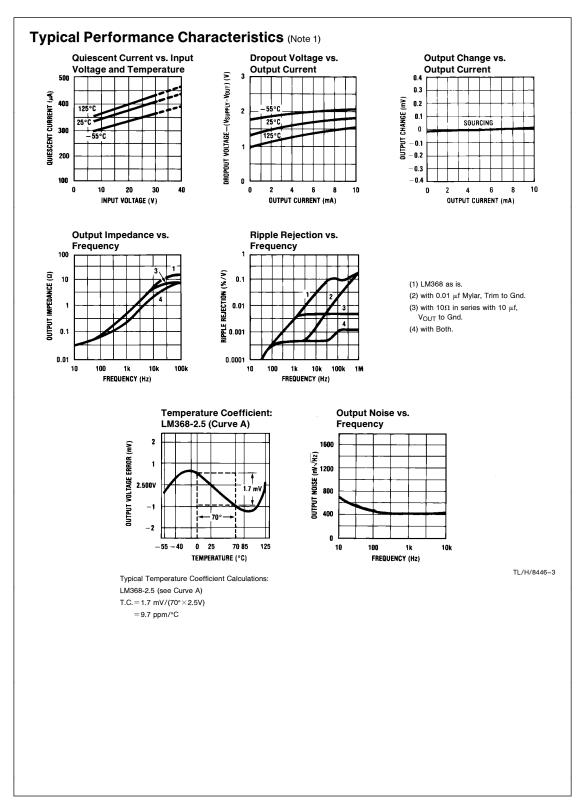
Note 4: Thermal Regulation is defined as the change in the output Voltage at a time T after a step change in power dissipation of 100 mW.

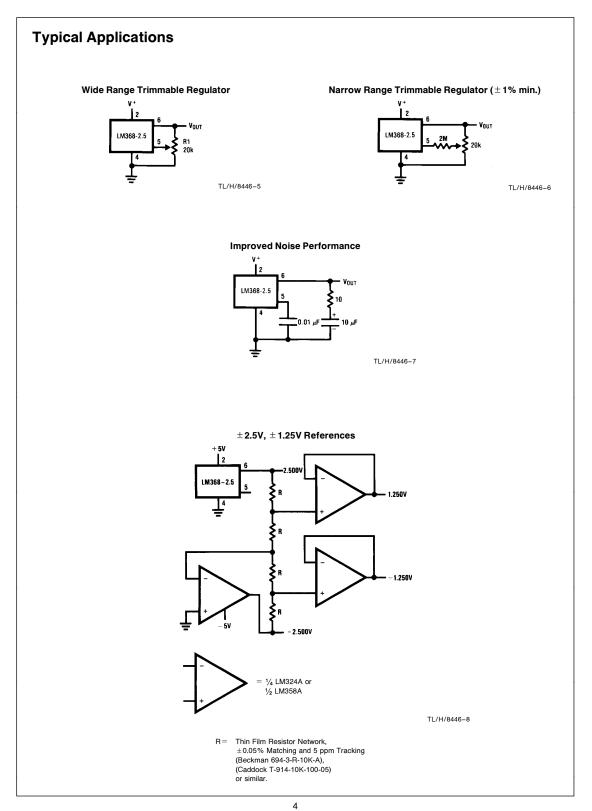
Note 5: Temperature Coefficient of V_{OUT} is defined as the worst case delta-V_{OUT} measured at Specified Temperatures divided by the total span of the Specified Temperature Range (See graphs). There is no guarantee that the Specified Temperatures are exactly at the minimum or maximum deviation.

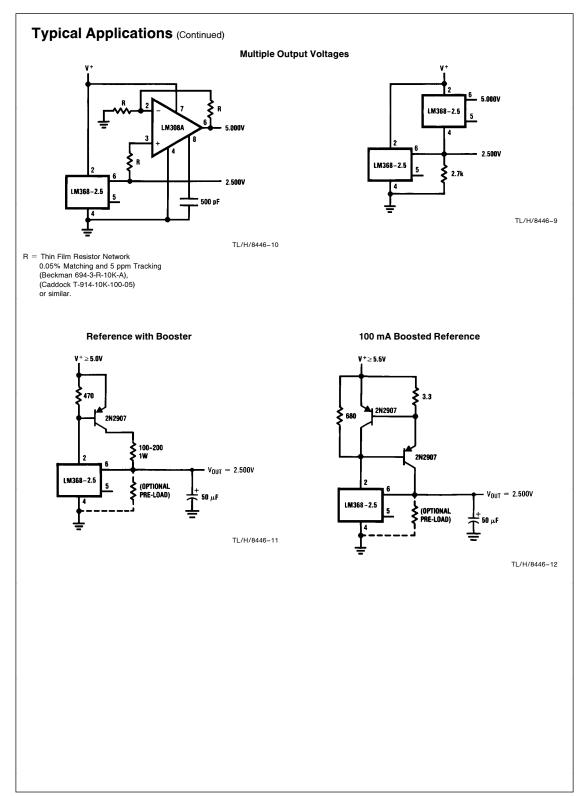
Note 6: In metal can (H), θ_{J-C} is 75°C/W and θ_{J-A} is 150°C/W.

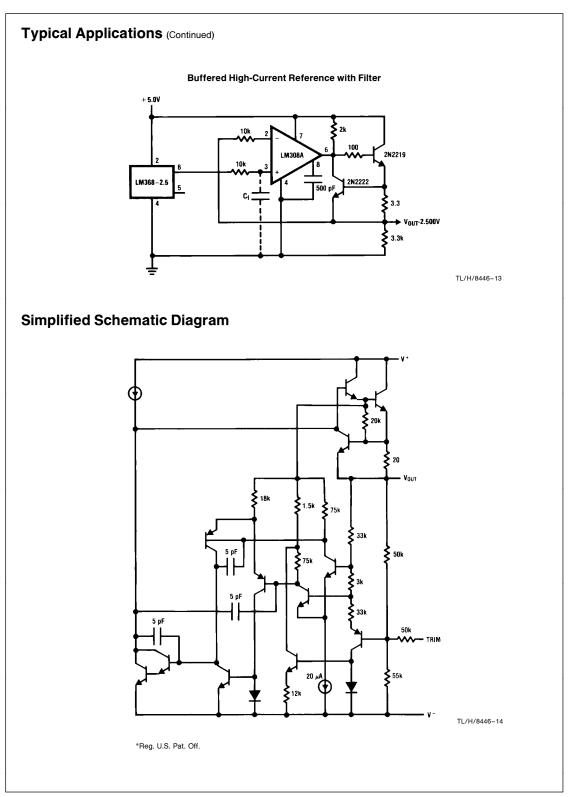
Note 7: Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. DC and AC electrical specifications do not apply when operating the device beyond its Rated Operating Conditions (see Note 1 and Conditions).

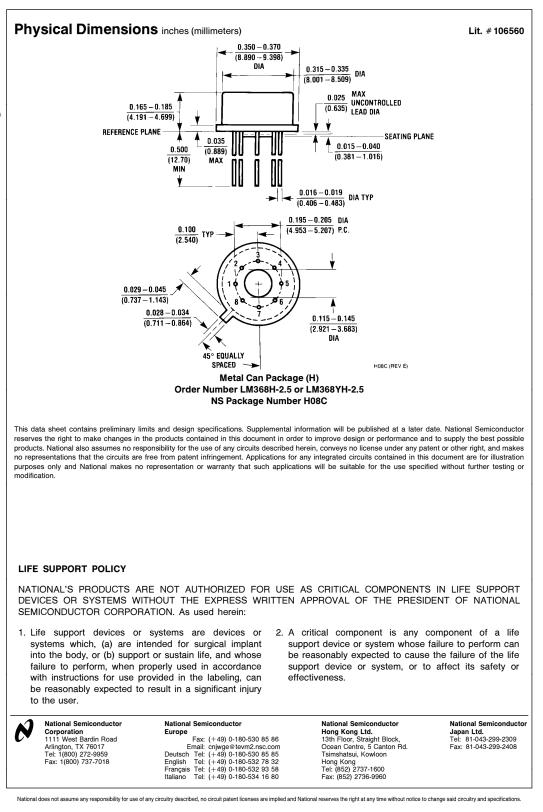
Note 8: Load regulation is measured on the output pin at a point 1/6" below the base of the package. Regulation is measured at constant junction temperature, using pulse testing with a low duty cycle. Changes in output voltage due to heating effects are covered under the specification for thermal regulation.











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